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| Inputs Are TTL-Voltage Compatible Parallel-to-Serial, Serial-to-Parallel | DW OR N PACKAGE (TOP VIEW) |
|---|--|
| Conversions | |
| Left or Right Shifts | $Q_A \begin{bmatrix} 2 & 19 \end{bmatrix} S1$ |
| Parallel Synchronous Loading | Q _B [] 3 18] A |
| Direct Overriding Clear | |
| Temporary Data Latching Capability | GND 5 16 V _{CC} GND 6 15 V _{CC} |
| Center-Pin V_{CC} and GND Configurations | GND [] 7 14] C |
| Minimize High-Speed Switching Noise | Q _C [] 8 13 [] D |
| EPIC[™] (Enhanced-Performance Implanted | Q _D [] 9 12 [] <u>CLR</u> |
| CMOS) 1-μm Process | SL SER 10 11 CLK |
| • 500-mA Typical Latch-Up Immunity | |

- at 125°C
- Package Options Include Plastic **Small-Outline Packages and Standard** Plastic 300-mil DIPs

description

This bidirectional shift register features parallel outputs, right-shift and left-shift serial inputs, operating-mode-control inputs, and a direct overriding clear line. The register has four distinct modes of operation, namely:

Parallel (broadside) load Shift right (in the direction Q_A toward Q_D) Shift left (in the direction Q_D toward Q_A) Inhibit clocking (do nothing).

Synchronous parallel loading is accomplished by applying the 4 bits of data and taking both mode control inputs, S0 and S1, high. The data are loaded into the associated flip-flops and appear at the outputs after the positive transition of the clock input. During loading, serial data flow is inhibited.

Shift right is accomplished synchronously with the rising edge of the clock pulse when S0 is high and S1 is low. Serial data for this mode is entered at the shift-right data input. When S0 is low and S1 is high, data shifts left synchronously and new data is entered at the shift-left serial inputs. Clocking of the flip-flop is inhibited when both mode control inputs are low.

The 74ACT11194 is characterized for operation from – 40°C to 85°C.

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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| _ | FUNCTION TABLE | | | | | | | | | | | | |
|---|----------------|----|-----|------|-------|---|------|------|------|-----------------|--|-----------------|-----------------|
| | INPUTS | | | | | | | OUT | PUTS | | | | |
| | MC | DE | CLK | SEF | RIAL | | PARA | LLEL | | 0. | Q _A Q _B Q _C | 0.0 | 0 |
| | S1 | S0 | ULK | LEFT | RIGHT | Α | В | С | D | ₽₽ | | ЧC | QD |
| L | Х | Х | Х | Х | Х | Х | Х | Х | Х | L | L | L | L |
| н | х | Х | L | Х | Х | Х | Х | Х | Х | Q _{A0} | Q _{B0} | Q _{C0} | Q _{D0} |
| н | н | Н | ↑ | Х | Х | а | b | с | d | а | b | С | d |
| н | L | Н | ↑ | Х | Н | Х | Х | Х | Х | н | Q _{An} | Q _{Bn} | Q _{Cn} |
| н | L | Н | ↑ | Х | L | Х | Х | Х | Х | L | Q _{An} | Q _{Bn} | QCn |
| н | н | L | ↑ | Н | Х | Х | Х | Х | Х | Q _{Bn} | QCn | Q _{Dn} | Н |
| н | н | L | ↑ | L | Х | Х | Х | Х | Х | Q _{Bn} | Q _{Cn} | Q _{Dn} | L |
| н | L | L | Х | Х | Х | Х | Х | Х | Х | Q _{A0} | Q _{B0} | Q _{C0} | Q _{D0} |

H = high level (steady state)

L = low level (steady state)

X = irrelevant (any input, including transitions)

 \uparrow = transition from low to high level

a,b,c,d = the level of steady-state input at inputs A, B, C, or D, respectively.

 Q_{A0} , Q_{B0} , Q_{C0} , Q_{D0} = the level of Q_A , Q_B , Q_C , or Q_D , respectively, before the indicated steady-state input conditions were established.

 Q_{An} , Q_{Bn} , Q_{Cn} , Q_{Dn} = the level of Q_A , Q_B , Q_C , or Q_D respectively, before the most-recent \uparrow transition of the clock.

timing clear, load, right-shift, inhibit, and clear sequences





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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



Parallel Outputs



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

| Supply voltage range, V _{CC} | $\dots \dots $ |
|--|--|
| Input voltage range, VI (see Note 1) | $\dots \dots -0.5$ V to V _{CC} + 0.5 V |
| Output voltage range, V _O (see Note 1) | $\dots \dots -0.5$ V to V _{CC} + 0.5 V |
| Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) | $\dots \dots \pm 20 \text{ mA}$ |
| Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) | $\dots \dots \pm 50 \text{ mA}$ |
| Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$ | $\dots \dots \pm 50 \text{ mA}$ |
| Continuous current through V _{CC} or GND | ± 100 mA |
| Storage temperature range | 65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

| | | MIN | NOM | MAX | UNIT |
|---------------------|------------------------------------|------|-----|-----|------|
| VCC | Supply voltage | 4.5 | | 5.5 | V |
| VIH | High-level input voltage | 2 | | | V |
| VIL | Low-level input voltage | | | 0.8 | V |
| VI | Input voltage | 0 | | VCC | V |
| VO | Output voltage | 0 | | VCC | V |
| IOH | High-level output current | | | -24 | mA |
| IOL | Low-level output current | | | 24 | mA |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | 0 | | 10 | ns/V |
| TA | Operating free-air temperature | - 40 | | 85 | °C |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | Vaa | Т | ₄ = 25°C | ; | MIN | МАХ | UNIT |
|-----------|---|-----------------|------|-----------------|-------|------|------|------|
| PARAMETER | | V _{CC} | MIN | TYP | MAX | | | UNIT |
| Vон | | 4.5 V | 4.4 | | | 4.4 | | |
| | I _{OH} = - 50 μA | 5.5 V | 5.4 | | | 5.4 | | |
| | | 4.5 V | 3.94 | | | 3.8 | | V |
| | I _{OH} = – 24 mA | | 4.94 | | | 4.8 | | |
| | $I_{OH} = -75 \text{ mA}^{\ddagger}$ | 5.5 V | | | | 3.85 | | |
| | 1 | 4.5 V | | | 0.1 | | 0.1 | |
| | I _{OL} = 50 μA | 5.5 V | | | 0.1 | | 0.1 | |
| VOL | I _{OL} = 24 mA | 4.5 V | | | 0.36 | | 0.44 | V |
| | | 5.5 V | | | 0.36 | | 0.44 | |
| | $I_{OL} = 75 \text{ mA}^{\ddagger}$ | 5.5 V | | | | | 1.65 | |
| lj | $V_{I} = V_{CC}$ or GND | 5.5 V | | | ± 0.1 | | ±1 | μA |
| ICC | $V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$ | 5.5 V | | | 8 | | 80 | μA |
| ∆ICC§ | One input at 3.4 V, Other inputs at GND or V_{CC} | 5.5 V | | | 0.9 | | 1 | mA |
| Ci | V _I = V _{CC} or GND | 5 V | | 4 | | | | pF |

[‡]Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

§ This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V to V_{CC}.



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timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

| | | | T _A = 2 | T _A = 25°C | | MIN MAX | |
|------------------|----------------------------------|-----------------|--------------------|-----------------------|--------|---------|------|
| | | | MIN | MAX | IVIIIN | IVIAA | UNIT |
| fclock | Clock frequency | | 0 | 100 | 0 | 100 | MHz |
| t Dulas duration | Pulse duration | CLK high or low | 5 | | 5 | | ns |
| t _w | | CLR low | 4.5 | | 4.5 | | 115 |
| | | Select | 6 | | 6 | | |
| t _{su} | Setup time before CLK \uparrow | Data | 4 | | 4 | | ns |
| | | CLR inactive | 1 | | 1 | | |
| +. | Hold time after CLK ↑ | Select | 1.5 | | 1.5 | | |
| th | | Data | 1 | | 1 | | ns |

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM | то | Т | ן = 25°C | ; | MIN | MAX | UNIT |
|------------------|---------|----------|-----|----------|-----|-----|------|------|
| PARAMETER | (INPUT) | (OUTPUT) | MIN | TYP | MAX | | | UNIT |
| fmax | | | 100 | 130 | | 100 | | MHz |
| ^t PLH | 01/ | 4774 0 | 2.2 | 5.8 | 6.9 | 2.2 | 7.7 | |
| ^t PHL | CLK | Any Q | 2.6 | 6.6 | 7.7 | 2.6 | 8.8 | ns |
| ^t PLH | CLR | Any Q | 2.9 | 7.1 | 9.1 | 2.9 | 10.3 | ns |

operating characteristics, V_{CC} = 5 V, T_A = 25°C

| PARAMETER | TEST CONDITIONS | TYP | UNIT |
|---|---|-----|------|
| C _{pd} Power dissipation capacitance | $C_L = 50 \text{ pF}, \qquad f = 1 \text{ MHz}$ | 69 | pF |



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NOTES: A. CL includes probe and jig capacitance.

B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f = 3 ns, t_f = 3 ns.

C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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